Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination
JIAO ET AL.

Examiner

Jacob Y Choi

Applicant(s)/Patent Under Reexamination
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Class	ification
	Α	US-6168293-B1	01-2001	Lieszkovszky et al.	362	297
	В	US-5975723-	11-1999	Daumueller et al.	362	297
	С	US-5136491-	08-1992	Kano	362	346
	D	US-4730240-	03-1988	van Meel et al.	362	346
	Е	US-4683525-	07-1987	Camm	362	346
	F	US				
	G	US				
	Н	US				
	-	US				
	7	US				
	К	US				
	L	US				
	M	US				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	-				
	0	- · -				
	Р					
	Q	-				
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	х	

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